

# Qualification Results Summary for AD548 Wilmington Bipolar Process Change From 4" to 6" Wafer Diameter

| QUALIFICATION RESULTS                                                |                                |                                |                                                    |
|----------------------------------------------------------------------|--------------------------------|--------------------------------|----------------------------------------------------|
| Test                                                                 | Specification                  | Sample Size                    | Results                                            |
| High Temperature Operating Life (HTOL)*                              | JEDEC <i>JESD22-A108</i>       | <b>7 x 45</b><br><b>2 x 77</b> | <b>Pass</b>                                        |
| Highly Accelerated Stress Test (HAST)*                               | JEDEC <i>JESD22-A110</i>       | <b>7 x 45</b>                  | <b>Pass</b>                                        |
| Temperature Cycle (TC)*                                              | JEDEC <i>JESD22-A104</i>       | <b>5 x 45</b><br><b>4 x 77</b> | <b>Pass</b>                                        |
| Autoclave (AC)*                                                      | JEDEC <i>JESD22-A102</i>       | <b>5 x 45</b><br><b>4 x 77</b> | <b>Pass</b>                                        |
| High Temperature Storage Life (HTSL)                                 | JEDEC <i>JESD22-A103</i>       | <b>7 x 77</b>                  | <b>Pass</b>                                        |
| Latch-Up                                                             | JEDEC <i>JESD78</i>            | <b>1 x 12</b>                  | <b>Pass</b><br><b>+/- 200mA @</b><br><b>+22.5V</b> |
| Electrostatic Discharge<br><i>Human Body Model</i>                   | ESDA/JEDEC <i>JDS-001-2011</i> | <b>1 x 24</b>                  | <b>Pass ±700V</b>                                  |
| Electrostatic Discharge<br><i>Field-Induced Charged Device Model</i> | JEDEC <i>JESD22-C101</i>       | <b>1 x 18</b>                  | <b>Pass ±1250V</b>                                 |

\*Preconditioned per JEDEC/IPC J-STD-020